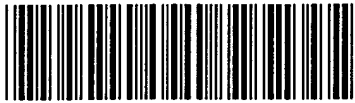


**Search Notes**

Application/Control No.

10/526,771

Examiner

Ives Wu

Applicant(s)/Patent under  
Reexamination

ONISHI ET AL.

Art Unit

1724

**SEARCHED**

Class	Subclass	Date	Examiner
524	502	12/27/2006	IWU

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
text search - EAST	12/28/2006	IWU